

P-Channel 30-V (D-S) MOSFET

| PRODUCT SUMMARY | | | | | | |
|---------------------|------------------------------------|---------------------------------|-----------------------|--|--|--|
| V _{DS} (V) | $R_{DS(on)}$ (Ω) | I _D (A) ^d | Q _g (Typ.) | | | |
| - 30 | 0.011 at V _{GS} = - 10 V | - 11.6 | 22 nC | | | |
| | 0.012 at V _{GS} = - 4.5 V | - 10 | 22 110 | | | |





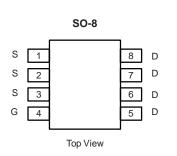
100 % R_g Tested
100 % UIS Tested

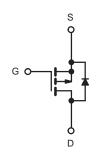
FEATURES





- · Load Switches
 - Notebook PCs
 - Desktop PCs





P-Channel MOSFET

| ABSOLUTE MAXIMUM RATINGS T | $_{A}$ = 25 °C, unless other | erwise noted | | | |
|--|-----------------------------------|-----------------|-----------------------|----|--|
| Parameter | Symbol | Limit | Unit | | |
| Drain-Source Voltage | V _{DS} | - 30 | V | | |
| Gate-Source Voltage | | V_{GS} | ± 20 | V | |
| | T _C = 25 °C | | - 11.6 | | |
| Continuous Drain Current (T. – 150 °C) | T _C = 70 °C | | - 10.5 | | |
| Continuous Drain Current (T _J = 150 °C) | T _A = 25 °C | l _D | - 8.7 ^{a, b} | | |
| | T _A = 70 °C | | - 7.7 ^{a, b} | | |
| Pulsed Drain Current | I _{DM} | - 40 | A | | |
| Continuous Course Dunin Diodo Current | T _C = 25 °C | | - 4.6 | | |
| Continuous Source-Drain Diode Current | T _A = 25 °C | - Is - | 2.0 ^{a, b} | | |
| Avalanche Current | 1 0411 | I _{AS} | - 20 | 1 | |
| Single-Pulse Avalanche Energy L = 0.1 n | | E _{AS} | 20 | mJ | |
| | T _C = 25 °C | | 5.6 | W | |
| Maximum Dawar Discipation | T _C = 70 °C |] , [| 3.6 | | |
| Maximum Power Dissipation | T _A = 25 °C | P _D | 2.5 ^{a, b} | | |
| | T _A = 70 °C | 1 | 1.6 ^{a, b} | | |
| Operating Junction and Storage Temperature Rang | T _J , T _{stg} | - 55 to 150 | °C | | |

| THERMAL RESISTANCE RATINGS | | | | | | |
|---|--------------|-------------------|---------|---------|-------|--|
| Parameter | | Symbol | Typical | Maximum | Unit | |
| Maximum Junction-to-Ambient ^{a, c} | t ≤ 10 s | R _{thJA} | 39 | 50 | °C/W | |
| Maximum Junction-to-Foot | Steady State | R _{thJF} | 18 | 22 | *C/vv | |

- a. Surface mounted on 1" x 1" FR4 board.
- c. Maximum under Steady State conditions is 85 °C/W. d. Based on $T_{\rm C}$ = 25 °C.



| Parameter | Symbol | Test Conditions | Min. | Тур. | Max. | Unit |
|---|-------------------------|--|-------|--------|-------|--------|
| Static | | | | | | |
| Drain-Source Breakdown Voltage | V _{DS} | $V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$ | - 30 | | | V |
| V _{DS} Temperature Coefficient | $\Delta V_{DS}/T_{J}$ | I _D = - 250 μA | | - 31 | | m\//9C |
| V _{GS(th)} Temperature Coefficient | $\Delta V_{GS(th)}/T_J$ | | | 5.5 | | mV/°C |
| Gate-Source Threshold Voltage | V _{GS(th)} | $V_{DS} = V_{GS}, I_{D} = -250 \mu\text{A}$ | - 1.0 | | - 3.0 | V |
| Gate-Source Leakage | I _{GSS} | $V_{DS} = 0 \text{ V}, V_{GS} = \pm 25 \text{ V}$ | | | ± 100 | nA |
| Zara Oata Vallana Brain Oamani | I _{DSS} | V _{DS} = - 30 V, V _{GS} = 0 V | | | - 1 | |
| Zero Gate Voltage Drain Current | | V _{DS} = - 30 V, V _{GS} = 0 V, T _J = 55 °C | | | - 5 | μA |
| On-State Drain Current ^a | I _{D(on)} | $V_{DS} \ge -10 \text{ V}, V_{GS} = -10 \text{ V}$ | - 30 | | | Α |
| Durin Orania On Otata Basista and | D | V _{GS} = - 10 V, I _D = - 10 A | | 0.011 | | |
| Drain-Source On-State Resistance ^a | R _{DS(on)} | V _{GS} = - 4.5 V, I _D = - 7 A | | 0.012 | | Ω |
| Forward Transconductance ^a | 9 _{fs} | V _{DS} = - 10 V, I _D = - 10 A | | 23 | | S |
| Dynamic ^b | | | | | | |
| Input Capacitance | C _{iss} | | | 1960 | | pF |
| Output Capacitance | C _{oss} | $V_{DS} = -15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$ | | 380 | | |
| Reverse Transfer Capacitance | C _{rss} | | | 325 | | |
| Total Cata Charra | | $V_{DS} = -15 \text{ V}, V_{GS} = -10 \text{ V}, I_{D} = -10 \text{ A}$ | | 43 | 65 | |
| Total Gate Charge | | | | 22 | 33 | nC |
| Gate-Source Charge | Q_{gs} | $V_{DS} = -15 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -10 \text{ A}$ | | 6 | | |
| Gate-Drain Charge | Q_{gd} | | | 11 | | |
| Gate Resistance | R _g | f = 1 MHz | 0.3 | 1.3 | 2.5 | Ω |
| Turn-On Delay Time | t _{d(on)} | | | 11 | 22 | |
| Rise Time | t _r | V_{DD} = - 15 V, R_L = 3 Ω | | 13 | 25 | 1 |
| Turn-Off DelayTime | t _{d(off)} | $I_D \cong -5 \text{ A}, V_{GEN} = -10 \text{ V}, R_g = 1 \Omega$ | | 32 | 50 | |
| Fall Time | ì _f | 1 | | 9 | 18 | |
| Turn-On Delay Time | t _{d(on)} | | | 44 | 70 | ns |
| Rise Time | ì, | V_{DD} = - 15 V, R_L = 3 Ω | | 100 | 160 | |
| Turn-Off DelayTime | t _{d(off)} | $I_D \cong$ - 5 A, V_{GEN} = - 4.5 V, R_g = 1 Ω | | 28 | 50 | |
| Fall Time | ì, |] | | 15 | 30 | |
| Drain-Source Body Diode Characterist | ics | | | | | |
| Continuous Source-Drain Diode Current | I _S | T _C = 25 °C | | | - 4.6 | ۸ |
| Pulse Diode Forward Current | I _{SM} | - | | | - 50 | Α |
| Body Diode Voltage | V _{SD} | $I_S = -2 \text{ A}, V_{GS} = 0 \text{ V}$ | | - 0.75 | - 1.2 | V |
| Body Diode Reverse Recovery Time | t _{rr} | | | 28 | 45 | ns |
| Body Diode Reverse Recovery Charge | Q _{rr} | 1 2 A d1/d+ 400 A/: T 05 00 | | 20 | 40 | nC |
| Reverse Recovery Fall Time | t _a | $I_F = -2 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$ | | 13 | | |
| Reverse Recovery Rise Time | t _b | | | 15 | | ns |

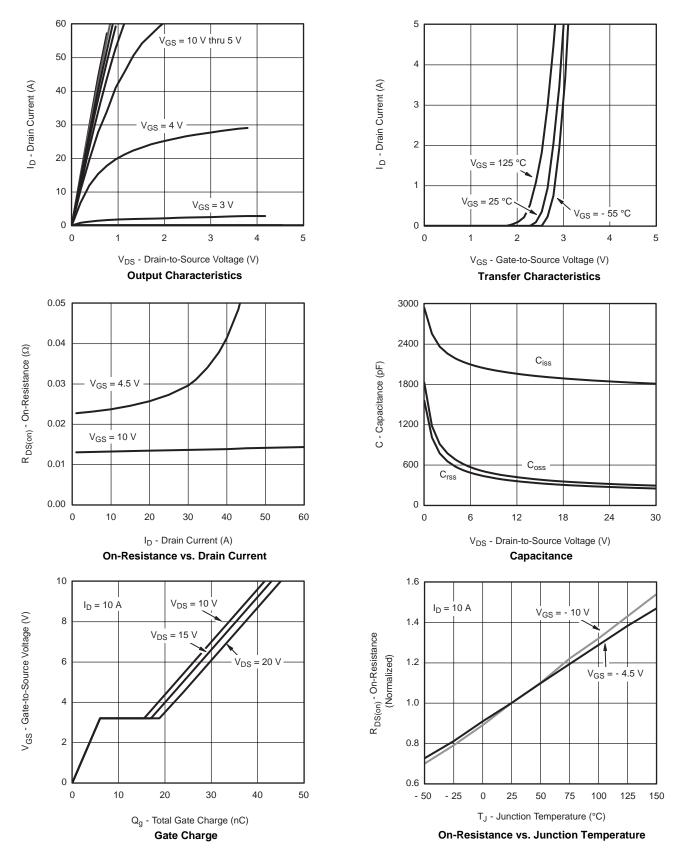
Notes:

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

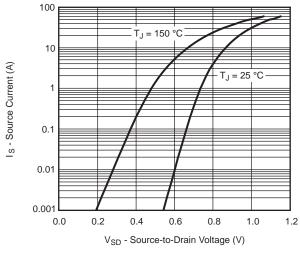
a. Pulse test; pulse width $\leq 300~\mu s,~duty~cycle \leq 2~\%.$

b. Guaranteed by design, not subject to production testing.

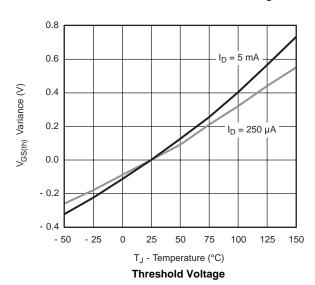






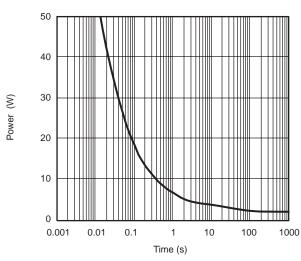


Source-Drain Diode Forward Voltage

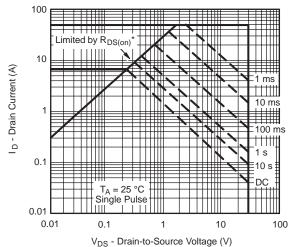


0.10 $I_{D} = 10 \text{ A}$ 0.08 $\mathsf{R}_{\,\mathsf{DS}(\mathsf{on})}$ - On-Resistance (Ω) 0.06 0.04 $T_J = 125~^{\circ}C$ 0.02 $T_J = 25 \, ^{\circ}C$ 0.00 0 8 10

V_{GS} - Gate-to-Source Voltage (V) On-Resistance vs. Gate-to-Source Voltage



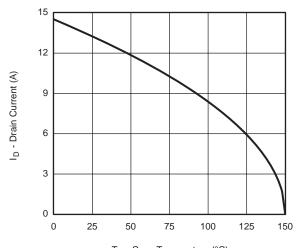
Single Pulse Power, Junction-to-Ambient



* V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

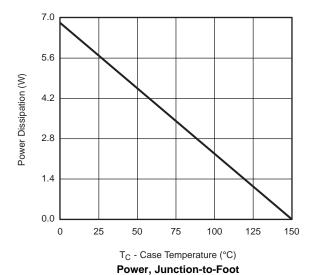
Safe Operating Area

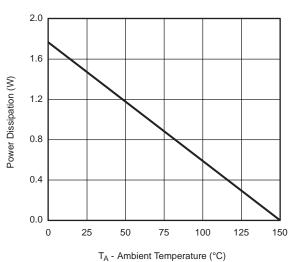




 $T_{\mbox{\scriptsize C}}$ - Case Temperature (°C)

Current Derating*

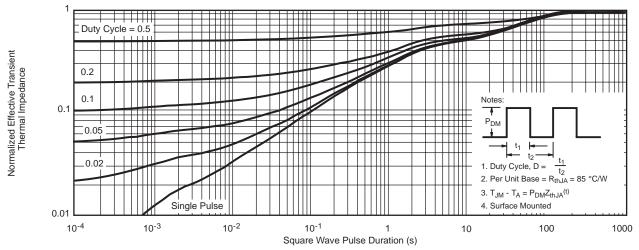




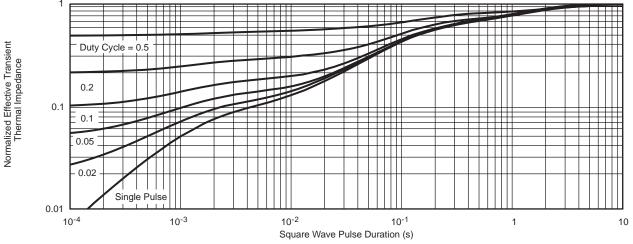
Power Derating, Junction-to-Ambient

^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

服务热线:400-655-8788 6



SOIC (NARROW): 8-LEADJEDEC Part Number: MS-012







| | MILLIM | IETERS | INC | HES | |
|------------------------------|--------|--------|-----------|-------|--|
| DIM | Min | Max | Min | Max | |
| Α | 1.35 | 1.75 | 0.053 | 0.069 | |
| A ₁ | 0.10 | 0.20 | 0.004 | 0.008 | |
| В | 0.35 | 0.51 | 0.014 | 0.020 | |
| С | 0.19 | 0.25 | 0.0075 | 0.010 | |
| D | 4.80 | 5.00 | 0.189 | 0.196 | |
| E | 3.80 | 4.00 | 0.150 | 0.157 | |
| е | 1.27 | BSC | 0.050 BSC | | |
| Н | 5.80 | 6.20 | 0.228 | 0.244 | |
| h | 0.25 | 0.50 | 0.010 | 0.020 | |
| L | 0.50 | 0.93 | 0.020 | 0.037 | |
| q | 0° | 8° | 0° | 8° | |
| S | 0.44 | 0.64 | 0.018 | 0.026 | |
| FCN: C-06527-Rev I 11-Sen-06 | | | | | |

ECN: C-06527-Rev. I, 11-Sep-06

DWG: 5498



RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads Dimensions in Inches/(mm)



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